

lfw

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Markus Cherdron et al.
Serial No. : 10/676,374
Filed : September 30, 2003
Title : DEVELOPMENT ENVIRONMENT FOR DEVELOPING APPLICATIONS
USING A METAMODEL

Art Unit : 2122
Examiner : Unknown

MAIL STOP AMENDMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Applicant submits the references listed on the attached form PTO-1449. This application was filed after July 1, 2003; therefore, only copies of foreign patent documents and non-patent literature are being furnished.

This statement is being filed within three months of the filing date of the application or before the receipt of a first Office action on the merits. Please apply any charges or credits to Deposit Account No. 06-1050.

Respectfully submitted,

Date: _____

8/12/04

J. Richard Soderberg
Reg. No. 43,352

PTO Customer Number 32864

Fish & Richardson P.C., P.A.
60 South Sixth Street
Suite 3300
Minneapolis, MN 55402
Telephone: (612) 335-5070
Facsimile: (612) 288-9696

60237871.doc

CERTIFICATE OF MAILING BY FIRST CLASS MAIL

I hereby certify under 37 CFR §1.8(a) that this correspondence is being deposited with the United States Postal Service as first class mail with sufficient postage on the date indicated below and is addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

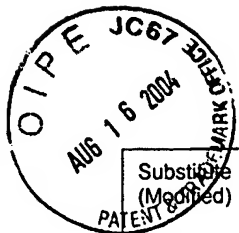
August 12, 2004

Date of Deposit

Signature

Debra L. Miedema

Typed or Printed Name of Person Signing Certificate



Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13913-122001	Application No. 10/676,374
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Markus Cherdron et al.	
		Filing Date September 30, 2003	Group Art Unit

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AA	Abrams, Mark, et al., "UIML: An XML Language for Building Device-Independent User Interfaces," December 1999, retrieved from the Internet on May 17, 2004, at http://www.harmonia.com/resources/papers/xml99Final.pdf , XP002280477, 15 pgs.
	AB	Abrams, Marc, et al., "User Interface Markup Language (UIML) Specification, Version 3.0," February 8, 2002, retrieved from the Internet on May 18, 2002, at http://www.uiml.org/specs/docs/uiml30-revised02-12-02.pdf , XP002280679, 116 pgs.
	AC	Ali, Mir Farooq, et al., "Building Multi-Platform User Interfaces with UML," November 9, 2001, retrieved from the Internet on May 17, 2004, at http://arxiv.org/ftp/cs/papers/0111/01111024.pdf , XP002280476, XP002280477, XP002280490, 12 pgs.
	AD	"Computer Science, abstract," Arxiv.org E-Print Archive, retrieved from the Internet on May 17, 2004, at http://arxiv.org/abs/cs.HC/0111024 , XP002280478, 1 pg.
	AE	Kagle, Kurt, et al., "Professional XSL," 2001, Wrox Press Ltd., Arden House, Birmingham, UK, XP002281359, pg. 742
	AF	Levine, John R., "Linkers & Loaders," 2000, Morgan Kaufmann Publishers, San Francisco, CA, XP002283283, pg. 48
	AG	Phanouriou, Constantinos, "UIML: A Device-Independent User Interface Markup Language," Virginia Polytechnic Institute and State University, September 26, 2000, retrieved from the Internet on May 17, 2004, at http://scholar.lib.vt.edu/theses/available/etd-08122000-19510051/unrestricted/PhanouriouETD.pdf , XP002280491, 172 pgs.
	AH	Phanouriou, Constantinos, "User Interface Markup Language (UIML) Draft Specification, Version 2.0a," January 17, 2000, retrieved from the Internet on May 17, 2004, at http://www.uiml.org/specs/docs/uiml20-17Jan00.pdf , XP002280490, 64 pgs.

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	